



Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
-18V	5.6m Ω @-4.5V	-34A
	6.0m Ω @-3.7V	
	7.0m Ω @-2.5V	
	10m Ω @-1.8V	

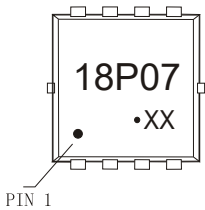
Feature

- High cell density trench P-ch MOSFETs
- Super low gate charge
- Advanced high cell density Trench technology

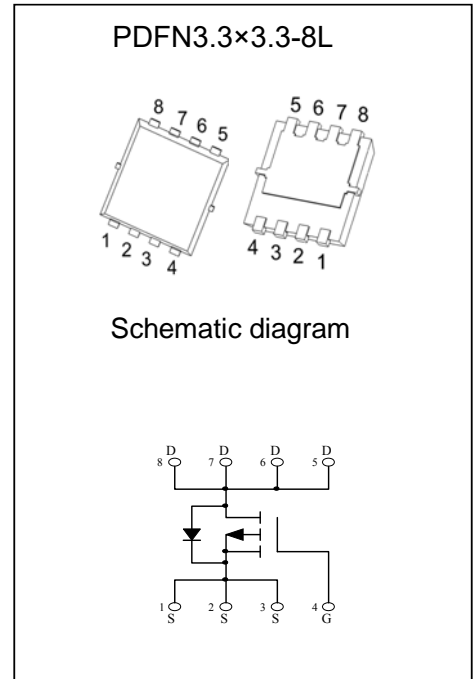
Application

- Battery protection applications
- Load switch

MARKING:



18P07 = Device Code
 XX = Date Code
 Solid Dot = Green Indicator



ABSOLUTE MAXIMUM RATINGS ($T_a=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	-18	V
Gate-Source Voltage	V_{GS}	± 12	V
Continuous Drain Current ¹	I_D	-34	A
Pulsed Drain Current ¹	I_{DM}	-102	A
Power Dissipation ²	P_D	3	W
Thermal Resistance from Junction to Ambient	$R_{\theta JA}$	42	$^{\circ}\text{C/W}$
Junction Temperature	T_J	150	$^{\circ}\text{C}$
Storage Temperature	T_{STG}	-55~ +150	$^{\circ}\text{C}$

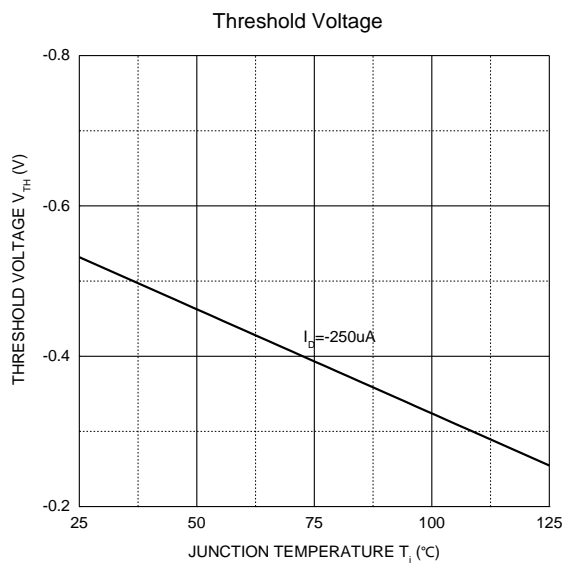
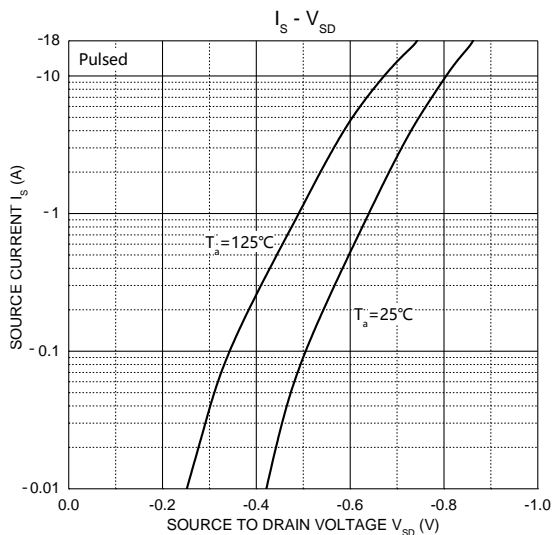
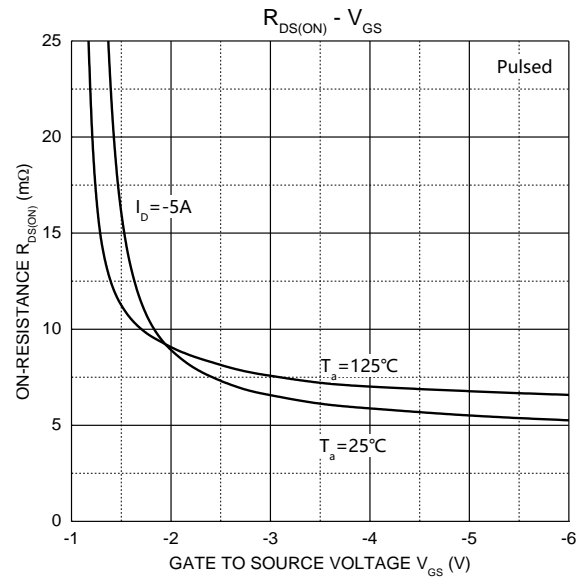
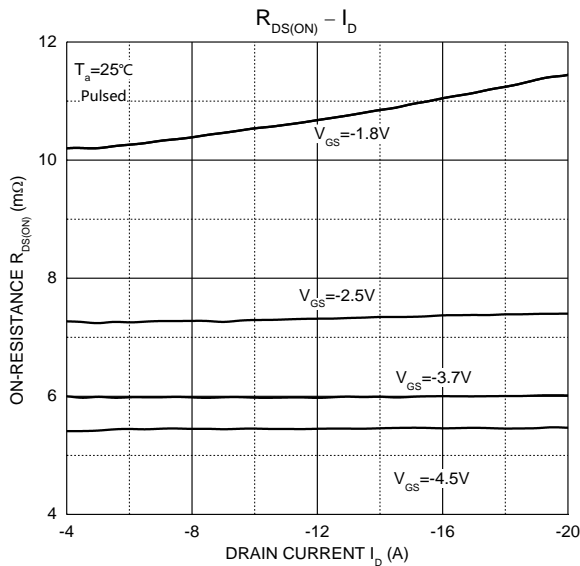
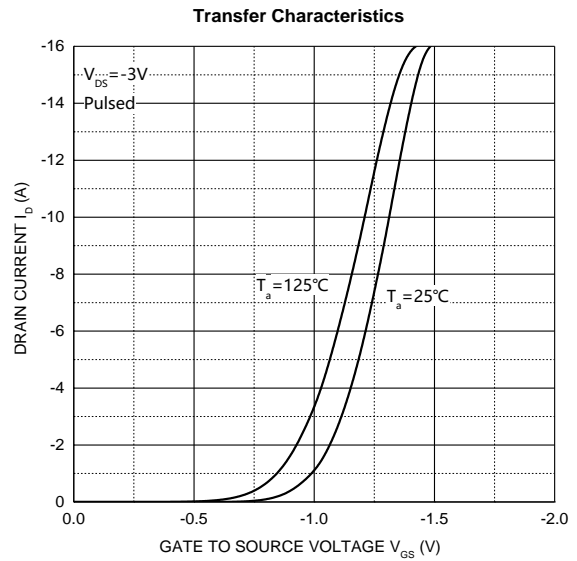
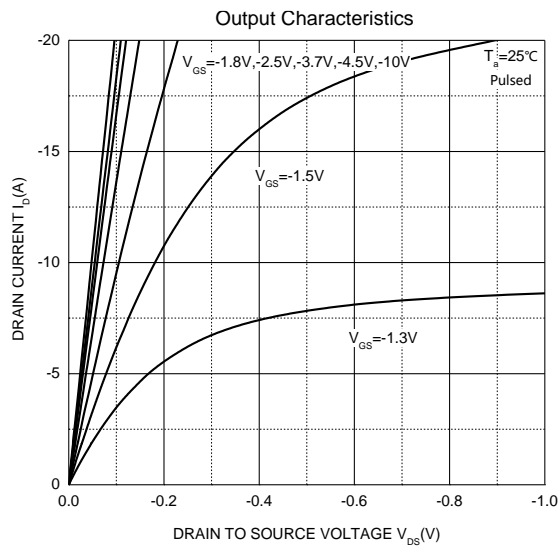
MOSFET ELECTRICAL CHARACTERISTICS(T_a=25°C unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Type	Max	Unit
Static Characteristics						
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = -250μA	-18			V
Zero gate voltage drain current	I _{DSS}	V _{DS} = -16V, V _{GS} = 0V			-1	μA
Gate-body leakage current	I _{GSS}	V _{GS} = ±12V, V _{DS} = 0V			±100	nA
Gate threshold voltage ³	V _{GS(th)}	V _{DS} = V _{GS} , I _D = -250μA	-0.35	-0.5	-1	V
Drain-source on-resistance ³	R _{DS(on)}	V _{GS} = -4.5V, I _D = -10A		5.6	7.3	mΩ
		V _{GS} = -3.7V, I _D = -10A		6.0	7.8	
		V _{GS} = -2.5V, I _D = -8A		7.0	9.4	
		V _{GS} = -1.8V, I _D = -6A		10	15	
Forward tranconductance ³	g _{FS}	V _{DS} = -6V, I _D = -10A	5			S
Dynamic characteristics						
Input Capacitance	C _{iss}	V _{DS} = -6V, V _{GS} = 0V, f = 1MHz		4850		pF
Output Capacitance	C _{oss}			1520		
Reverse Transfer Capacitance	C _{rss}			1610		
Gate resistance	R _g	f = 1MHz			30	Ω
Total Gate Charge	Q _g	V _{DS} = -6V, V _{GS} = -4.5V, I _D = -5A		65		nC
Gate-Source Charge	Q _{gs}			20		
Gate-Drain Charge	Q _{gd}			325		
Turn-on delay time	t _{d(on)}	V _{DD} = -6V, V _{GEN} = -4.5V, I _D = -4A R _L = 6Ω, R _{GEN} = 1Ω		22		ns
Turn-on rise time	t _r			50		
Turn-off delay time	t _{d(off)}			100		
Turn-off fall time	t _f			30		
Source-Drain Diode characteristics						
Diode forward current ⁴	I _S	T _C = 25°C			-34	A
Diode pulsed forward curren ⁴	I _{SM}				-102	A
Diode Forward voltage ³	V _{DS}	V _{GS} = 0V, I _S = -10A			-1.2	V

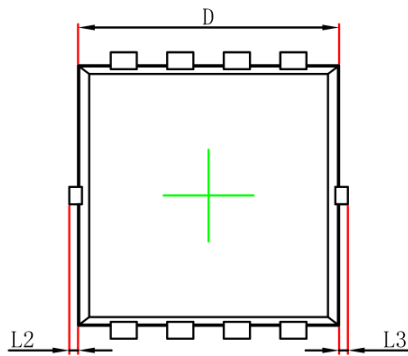
Notes:

1. Device mounted on FR-4 substrate board, with minimum recommended pad layout, single side.
2. The power dissipation is limited by 150°C junction temperature
3. Pulse Test : Pulse width ≤ 300μs, duty cycle ≤ 2%.
4. The data is theoretically the same as I_D, in real applications , should be limited by total power dissipation.

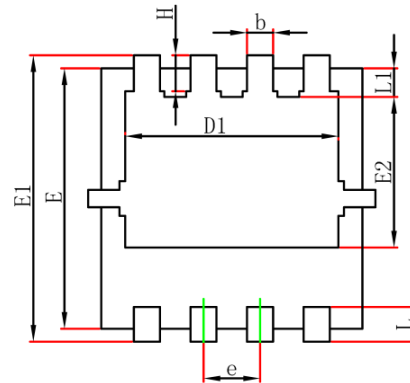
Typical Electrical and Thermal Characteristics



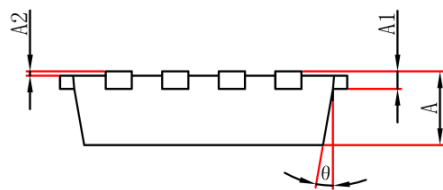
PDFN3.3x3.3-8L Package Information



Top View
[顶视图]



Bottom View
[背视图]



Side View
[侧视图]

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.700	0.900	0.028	0.035
A1	0.152REF		0.006REF	
A2	0.000	0.050	0.000	0.002
D	2.900	3.200	0.114	0.126
D1	2.300	2.600	0.091	0.102
E	2.900	3.200	0.114	0.126
E1	3.150	3.450	0.124	0.136
E2	1.535	1.935	0.060	0.076
b	0.200	0.400	0.008	0.016
e	0.550	0.750	0.022	0.030
L	0.300	0.500	0.012	0.020
L1	0.180	0.480	0.007	0.019
L2	0.000	0.100	0.000	0.004
L3	0.000	0.100	0.000	0.004
H	0.315	0.515	0.012	0.020
θ	0°	12°	0°	12°